

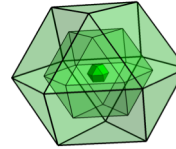


# Materials Science Seminar

## 13/2/2024 2:30 pm

### Grassano room

### Sogene Building



## Van der Waals epitaxy and characterization of quasi two-dimensional Ge-Sb-Te materials and heterostructures

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The advent of two-dimensional materials redefined the material science in the last decade, promising disrupting advances in many technological fields. Among the available synthesis techniques, van der Waals (vdW) epitaxy <sup>1</sup> ensures high quality, purity and scalability, all crucial for the integration with microelectronic technology.

Beyond the well-known phase change functionality used in non-volatile memories, the Ge-Sb-Te chalcogenide family possesses a generous variety of functional properties. As an example, the binary compound GeTe is the father of a new class of materials, namely ferroelectric Rashba semiconductors, in which ferroelectricity is used to control the spin texture at room temperature. <sup>2</sup> A key element for the exploitation of this rich playground is the high crystal quality achieved for the material deposited by molecular beam epitaxy (MBE) on Sb-passivated Si(111) substrates.

In this seminar, I will first give an overview on the fabrication by MBE of Ge-Sb-Te layered materials and heterostructures. <sup>3-5</sup> Next, I will present recent results on the vdW epitaxy and characterization of (1) GeTe-rich GST films, providing breakthrough evidence of their composition-dependent ferroelectric behavior, <sup>6</sup> and (2) the 1D chiral crystal tellurene, which has been integrated for the first time on silicon. Finally, I will discuss recent investigations on the crystallization and switching properties of Ge-rich GST films deposited amorphous by MBE. <sup>7</sup>

<sup>1</sup> A. Koma, "Van der Waals epitaxy—a new epitaxial growth method for a highly lattice-mismatched system," *Thin Solid Films* **216**(1), 72–76 (1992). <sup>2</sup> S. Varotto, L. Nesi, S. Cecchi et al., "Room-temperature ferroelectric switching of spin-to-charge conversion in germanium telluride," *Nature Electronics* **4**(10), 740–747 (2021). <sup>3</sup> S. Cecchi, E. Zallo, J. Momand et al., "Improved structural and electrical properties in native Sb<sub>2</sub>Te<sub>3</sub>/Ge<sub>x</sub>Sb<sub>2</sub>Te<sub>3+x</sub> van der Waals superlattices due to intermixing mitigation," *APL Materials* **5**(2), 026107 (2017). <sup>4</sup> R. Wang, F.R.L. Lange, S. Cecchi et al., "2D or not 2D: Strain tuning in weakly coupled heterostructures," *Adv. Funct. Mater.* **28**(14), 1705901 (2018). <sup>5</sup> S. Cecchi, D. Dragoni, D. Kriegner et al., "Interplay between Structural and Thermoelectric Properties in Epitaxial Sb<sub>2+x</sub>Te<sub>3</sub> Alloys," *Adv. Funct. Mater.* **29**(2), 1805184 (2019). <sup>6</sup> S. Cecchi, J. Momand, D. Dragoni et al., "Thick does the trick: genesis of ferroelectricity in two-dimensional GeTe-rich (GeTe)<sub>m</sub>(Sb<sub>2</sub>Te<sub>3</sub>)<sub>n</sub> lamellae," *Adv. Sci.* **11**(1), 2304785 (2024). <sup>7</sup> S. Cecchi, I. Lopez Garcia, A.M. Mio et al., "Crystallization and Electrical Properties of Ge-Rich GeSbTe Alloys," *Nanomaterials* **12**(4), 631 (2022).